

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination HAN ET AL.	
		Examiner Joseph Lauture	Art Unit 2819	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,825,784	11-2004	Zhang, Weibiao	341/131
	B	US-			
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	D	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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	S					
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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